•	Searc	 	

Application/Control No.	Applicant(s)/Pater Reexamination	Applicant(s)/Patent under Reexamination	
10/624,818	KAMON, HIDEKA	\ZU	
Examiner	Art Unit		
Christopher R. Lamb	2627		

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NO (INCLUDING SEARC)
	DATE	EXMR
Consulted SPE Wayne Young	4/4/2006	CRL
EAST Search	4/6/2006	CRL
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